

| | | | | |
|-----------------------------------|--|--|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination SUZUKI ET AL. | |
| | | 10/848,835 Examiner Hai H. Huynh | Art Unit 3747 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|------------------|----------------|
| A | US-5,836,187 A | 11-1998 | Janssen et al. | 70/252 |
| B | US-6,779,620 B2 | 08-2004 | Taniguchi et al. | 180/219 |
| C | US-6,515,580 B1 | 02-2003 | Isoda et al. | 340/425.5 |
| D | US-6,367,299 B1 | 04-2002 | Janssen et al. | 70/278.3 |
| E | US-2004/0207516 A1 | 10-2004 | Ohtaki et al. | 340/438 |
| F | US- | | | |
| G | US- | | | |
| H | US- | | | |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|---------|----------------|
| N | JP 2002-87368 | 03-2002 | Japan | Imamura | B62M 9/10 |
| O | JP 2000-16365 | 01-2000 | Japan | | B62J 9/00 |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | |
|---|---|--|
| U | | |
| V | | |
| W | | |
| X | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.